



SLOVENSKI STANDARD
SIST EN 61988-2-3:2010

01-januar-2010

Plošče s plazemskim prikazovalnikom - 2-3. del: Merilne metode - Kakovost (IEC 61988-2-3:2009)

Plasma display panels - Part 2-3: Measuring methods - Quality (IEC 61988-2-3:2009)

Plasmabildschirme - Teil 2-3: Messverfahren - Bildqualität: Defekte und Bildverschlechterung (IEC 61988-2-3:2009)

Panneaux d'affichage à plasma - Partie 2-3: Méthodes de mesure - Qualité (CEI 61988-2-3:2009)

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[SIST EN 61988-2-3:2010](https://standards.iteh.ai/catalog/standards/sist/84a4505-0e15-47be-bd14-1990c6ac61b/sist-en-61988-2-3-2010)

Ta slovenski standard je istoveten z: EN 61988-2-3:2009

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ICS:

31.120	Elektronske prikazovalne naprave	Electronic display devices
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SIST EN 61988-2-3:2010

en,fr



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SIST EN 61988-2-3:2010
01-januar-2010

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Plasma display panels - Part 2-3: Measuring methods - Quality (IEC 61988-2-3:2009)

Plasmabildschirme - Teil 2-3: Messverfahren - Bildqualität: Defekte und Bildverschlechterung (IEC 61988-2-3:2009)

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Panneaux d'affichage à plasma - Partie 2-3: Méthodes de mesure - Qualité (CEI 61988-2-3:2009)

[SIST EN 61988-2-3:2010](https://standards.iteh.ai/catalog/standards/sist/84a4505-0e15-47be-bd14-1990cabc1b/sist-en-61988-2-3-2010)

Ta slovenski standard je istoveten z: **EN 61988-2-3:2009**

ICS:

31.260	Optoelektronika, laserska oprema	Optoelectronics. Laser equipment
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SIST EN 61988-2-3:2010

en,fr

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EUROPEAN STANDARD
NORME EUROPÉENNE
EUROPÄISCHE NORM

EN 61988-2-3

November 2009

ICS 31.260

English version

**Plasma display panels -
Part 2-3: Measuring methods -
Image quality: defects and degradation
(IEC 61988-2-3:2009)**

Panneaux d'affichage à plasma -
Partie 2-3: Méthodes de mesure -
Qualité d'image: défauts
et dégradation
(CEI 61988-2-3:2009)

Plasmabildschirme -
Teil 2-3: Messverfahren -
Bildqualität: Defekte
und Bildverschlechterung
(IEC 61988-2-3:2009)

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This European Standard was approved by CENELEC on 2009-09-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

Foreword

The text of document 110/180/FDIS, future edition 1 of IEC 61988-2-3, prepared by IEC TC 110, Flat panel display devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61988-2-3 on 2009-09-01.

The following dates were fixed:

- latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2010-06-01
- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2012-09-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61988-2-3:2009 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 61966-5	NOTE	Harmonized as EN 61966-5:2009 (not modified).
IEC 61988-2-2	NOTE	Harmonized as EN 61988-2-2:2003 (not modified).

[SIST EN 61988-2-3:2010](https://standards.iteh.ai/catalog/standards/sist/f84a4505-0e15-47be-bd14-1990beafeb1b/sist-en-61988-2-3-2010)

<https://standards.iteh.ai/catalog/standards/sist/f84a4505-0e15-47be-bd14-1990beafeb1b/sist-en-61988-2-3-2010>

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-1	1988	Environmental testing - Part 1: General and guidance	EN 60068-1 ¹⁾	1994
IEC 60107-1	1997	Methods of measurement on receivers for television broadcast transmissions - Part 1: General considerations - Measurements at radio and video frequencies	EN 60107-1	1997
IEC 61988-1	- ²⁾	Plasma display panels - Part 1: Terminology and letter symbols	EN 61988-1	2003 ³⁾
IEC 61988-2-1	2002	Plasma display panels - Part 2-1: Measuring methods - Optical	EN 61988-2-1	2002
CIE 15	2004	Colorimetry	-	-

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¹⁾ EN 60068-1 includes A1:1992 to IEC 60068-1 + corr. October 1988.

²⁾ Undated reference.

³⁾ Valid edition at date of issue.

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IEC 61988-2-3

Edition 1.0 2009-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Plasma display panels – **STANDARD PREVIEW**
Part 2-3: Measuring methods – Image quality: defects and degradation
(standards.iteh.ai)

Panneaux d'affichage à plasma –
Partie 2-3: Méthodes de mesure – Qualité d'image: défauts et dégradation

1990beafeb1b/sist-en-61988-2-3-2010

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PLASMA DISPLAY PANELS –**Part 2-3: Measuring methods –
Image quality: defects and degradation**

FOREWORD

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International Standard IEC 61988-2-3 has been prepared by IEC technical committee 110: Flat panel display devices.

The text of this standard is based on the following documents:

FDIS	Report on voting
110/180/FDIS	110/188/RVD

Full information on the voting for the approval on this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts in the IEC 61988 series, under the general title *Plasma display panels*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

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